



100V 9.2mΩ N-Ch Power MOSFET

Features

- Ultra-low $R_{DS(ON)}$
- Low Gate Charge
- 100% UIS Tested, 100% R_g Tested
- Pb-free Lead Plating
- Halogen-free and RoHS-compliant

Product Summary

Parameter	Typ.	Unit
V_{DS}	100	V
$V_{GS(th)}_{typ}$	1.8	V
I_D (@ $V_{GS} = 10V$) ⁽¹⁾	11	A
$R_{DS(ON)}$ (@ $V_{GS} = 10V$)	9.2	mΩ
$R_{DS(ON)}$ (@ $V_{GS} = 4.5V$)	11.8	mΩ

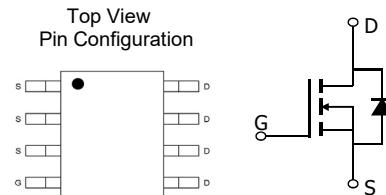
Applications

- Power Management in Telecom., Industrial Automation, CE
- Current Switching in DC/DC & AC/DC Sub-systems
- Motor Driving in Power Tool, E-vehicle, Robotics

SOP-8L Top View



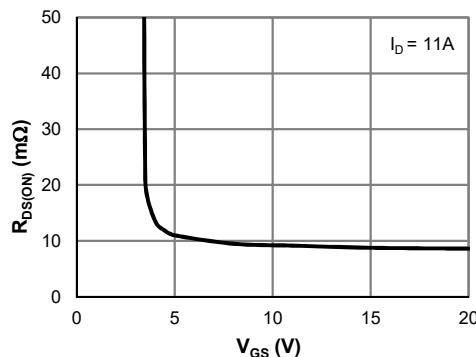
SOP-8L Bottom View

Top View
Pin Configuration**Ordering Information**

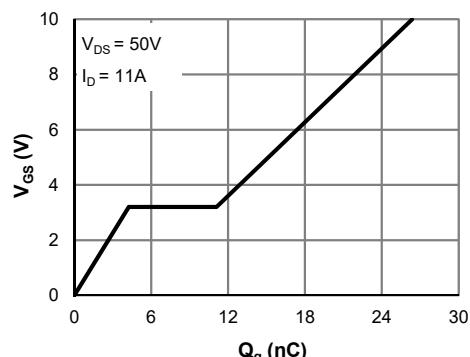
Device	Package	# of Pins	Marking	MSL	T_J (°C)	Media	Quantity (pcs)
JMSL1010AP-13	SOP-8L	8	SL1010A	3	-55 to 150	13-inch Reel	2500

Absolute Maximum Ratings (@ $T_A = 25^\circ C$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DS}	100	V
Gate-to-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ⁽¹⁾	I_D	11.1	A
$T_A = 70^\circ C$		8.9	
Pulsed Drain Current ⁽²⁾	I_{DM}	34	A
Avalanche Current ⁽³⁾	I_{AS}	32	A
Avalanche Energy ⁽³⁾	E_{AS}	51	mJ
Power Dissipation ⁽⁴⁾	P_D	2.5	W
$T_A = 25^\circ C$		1.6	
Junction & Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

 $R_{DS(ON)}$ vs. V_{GS} 

Gate Charge



Electrical Characteristics (@ $T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	100			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 80\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			1.0	μA
					5.0	
Gate-Body Leakage Current	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.8	2.5	V
Static Drain-Source ON-Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 11\text{A}$		9.2	11.1	$\text{m}\Omega$
	$R_{DS(\text{ON})}$	$V_{GS} = 4.5\text{V}, I_D = 5\text{A}$		11.8	14.8	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{DS} = 5\text{V}, I_D = 11\text{A}$		30		S
Diode Forward Voltage	V_{SD}	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.70	1.0	V
Diode Continuous Current	I_S	$T_A = 25^\circ\text{C}$			2.5	A
DYNAMIC PARAMETERS⁽⁵⁾						
Input Capacitance	C_{iss}	$V_{GS} = 0\text{V}, V_{DS} = 50\text{V}, f = 1\text{MHz}$		1535		pF
Output Capacitance	C_{oss}			335		pF
Reverse Transfer Capacitance	C_{rss}			8.2		pF
Gate Resistance	R_g	$V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$		1.8		Ω
SWITCHING PARAMETERS⁽⁵⁾						
Total Gate Charge (@ $V_{GS} = 10\text{V}$)	Q_g	$V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 50\text{V}, I_D = 11\text{A}$		26		nC
Total Gate Charge (@ $V_{GS} = 4.5\text{V}$)	Q_g			14.0		nC
Gate Source Charge	Q_{gs}			4.3		nC
Gate Drain Charge	Q_{gd}			6.8		nC
Turn-On DelayTime	$t_{D(\text{on})}$	$V_{GS} = 10\text{V}, V_{DS} = 50\text{V}$ $R_L = 4.5\Omega, R_{\text{GEN}} = 6\Omega$		7.5		ns
Turn-On Rise Time	t_r			15.7		ns
Turn-Off DelayTime	$t_{D(\text{off})}$			31		ns
Turn-Off Fall Time	t_f			28		ns
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 11\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		50		ns
Body Diode Reverse Recovery Charge	Q_{rr}	$I_F = 11\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		70		nC

Thermal Performance

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Ambient ($t \leq 10\text{s}$)	$R_{\theta JA}$	40	50	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient (steady state)	$R_{\theta JA}$	70	85	$^\circ\text{C/W}$

Notes:

1. Computed continuous current assumes the condition of $T_{J_{\text{Max}}}$ while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under $T_{J_{\text{Max}}} = 150^\circ\text{C}$.
3. This single-pulse measurement was taken under the following condition [$L = 100\mu\text{H}, V_{GS} = 10\text{V}, V_{DS} = 50\text{V}$] while its value is limited by $T_{J_{\text{Max}}} = 150^\circ\text{C}$.
4. The power dissipation P_D is based on $T_{J_{\text{Max}}} = 150^\circ\text{C}$.
5. This value is guaranteed by design hence it is not included in the production test.

Typical Electrical & Thermal Characteristics

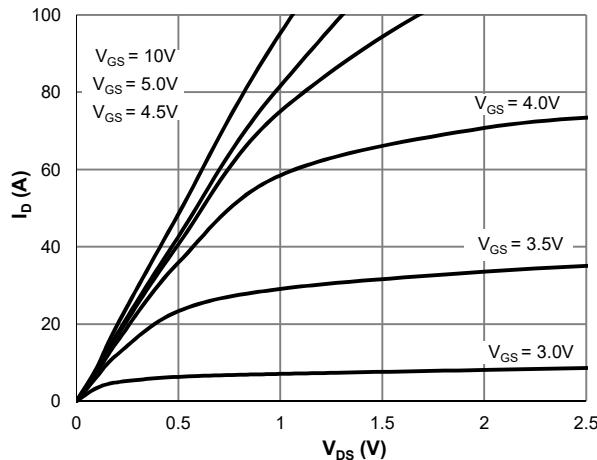


Figure 1: Saturation Characteristics

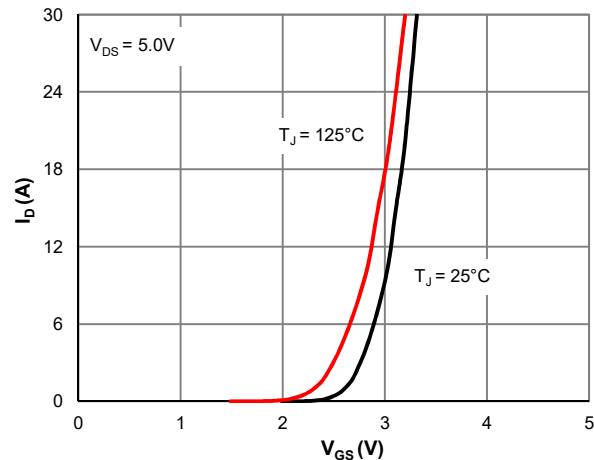


Figure 2: Transfer Characteristics

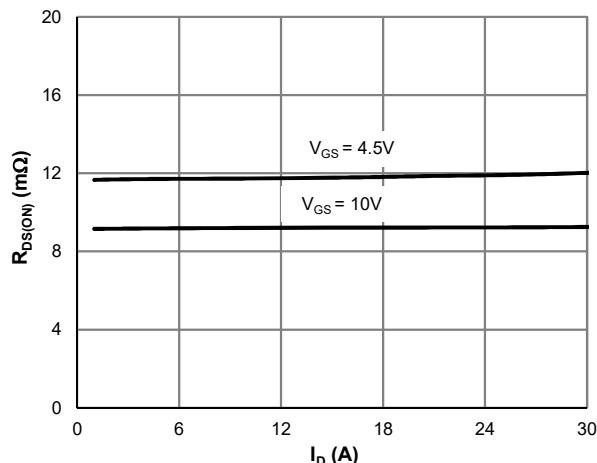


Figure 3: $R_{DS(ON)}$ vs. Drain Current

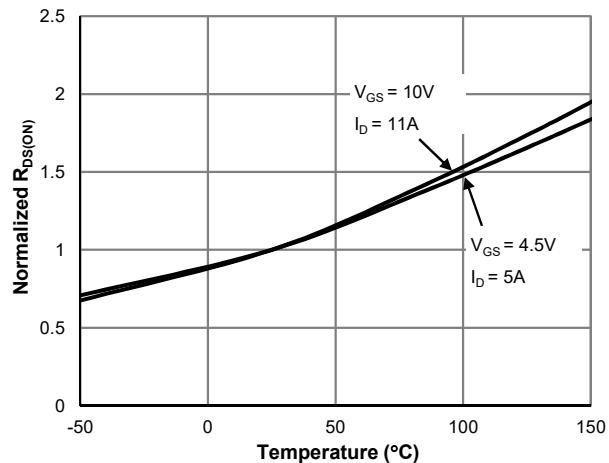


Figure 4: $R_{DS(ON)}$ vs. Junction Temperature

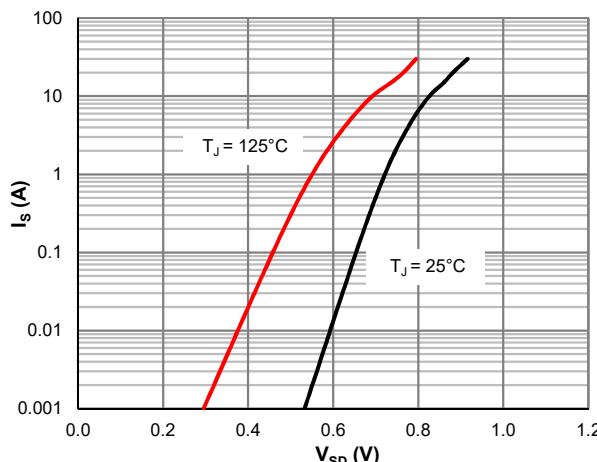


Figure 5: Body-Diode Characteristics

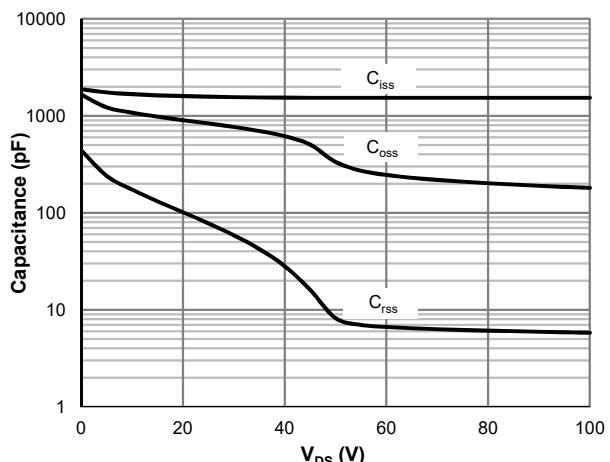


Figure 6: Capacitance Characteristics

Typical Electrical & Thermal Characteristics

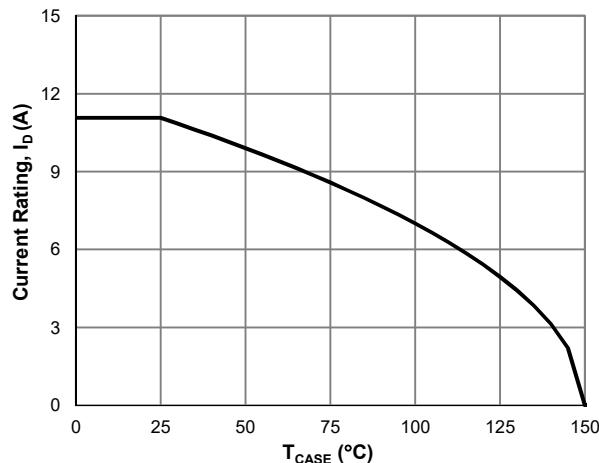


Figure 7: Current De-rating

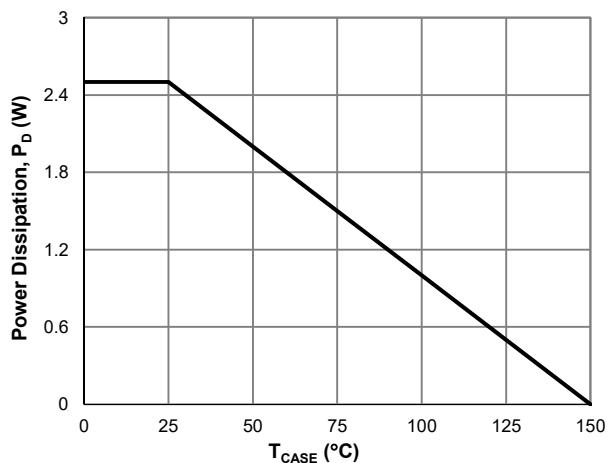


Figure 8: Power De-rating

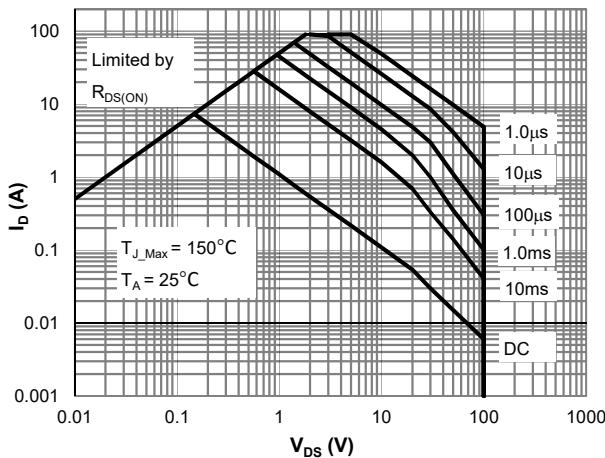


Figure 9: Maximum Safe Operating Area

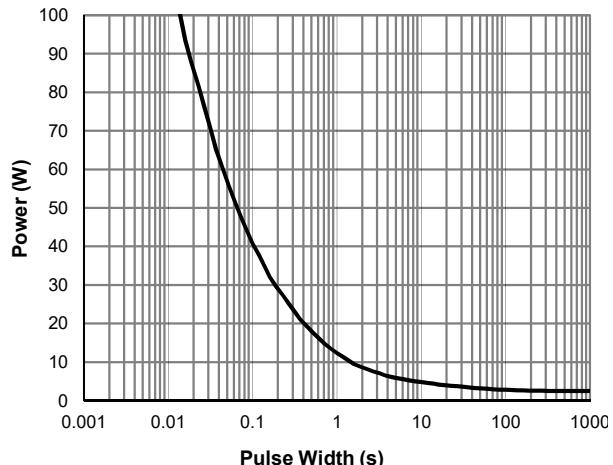


Figure 10: Single Pulse Power Rating, Junction-to-Case

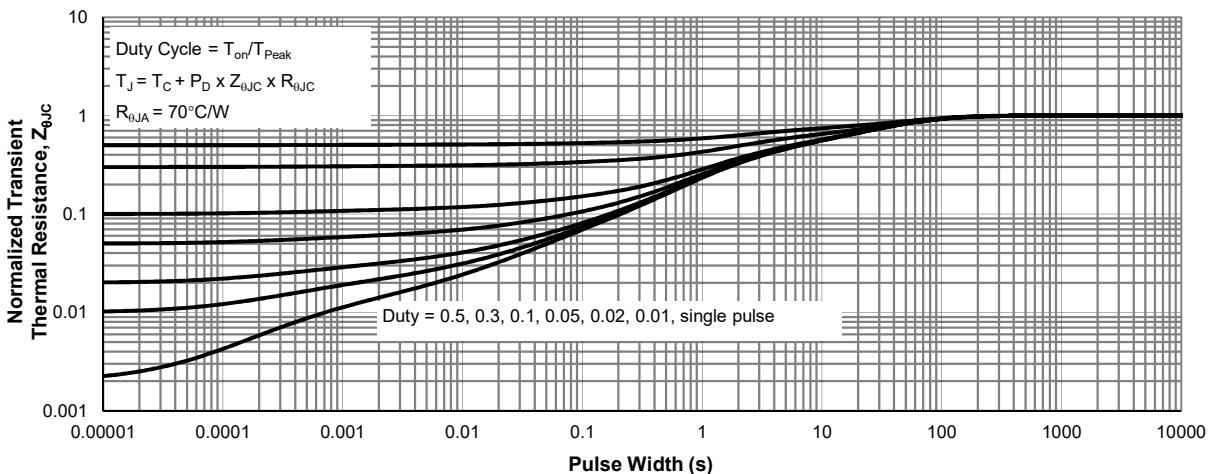
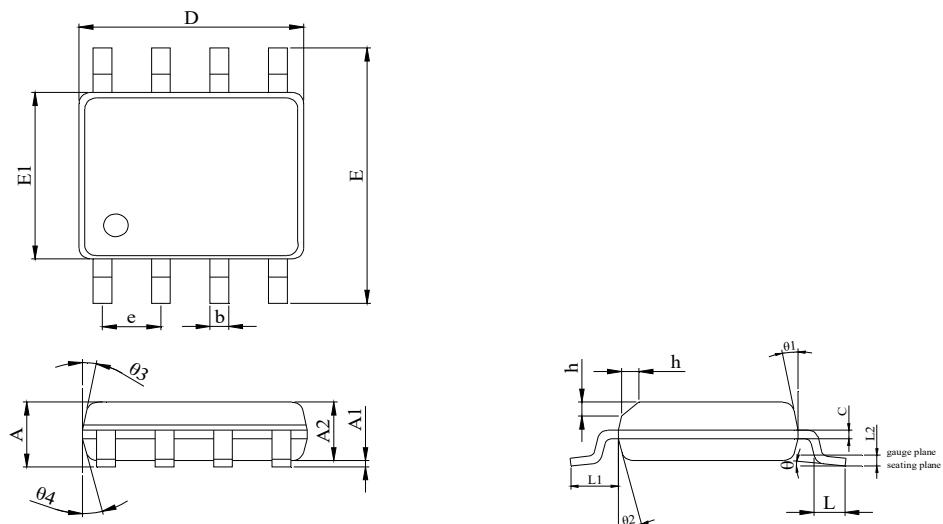


Figure 11: Normalized Maximum Transient Thermal Impedance

SOP-8L Package Information
Package Outline


DIM	MILLIMETER		
	MIN.	NOM.	MAX.
A	1.35	1.50	1.65
A1	0.05	0.10	0.15
A2	1.35	1.40	1.50
b	0.38	--	0.50
c	0.17	--	0.25
D	4.80	4.90	5.00
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
e	1.27(BSC)		
L	0.45	0.60	0.80
L1	1.04 REF		
L2	0.25 BSC		
h	0.30	0.40	0.50
theta	0°	--	8°
theta1	10°	12°	14°
theta2	8°	10°	12°
theta3	10°	12°	14°
theta4	8°	10°	12°

Recommended Footprint
